Beam Monitors for the slow-extraction beam line at J-PARC

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Beam intensity measurement in KEK-PS extraction beam line

- Secondary emission Electron Chamber (SEC)
 - Good linearity and stability
 - Need vacuum window (Al 100 μm)
 - Deterioration of Al foil
 - after ~ 10¹⁸ proton / cm² irradiation (K. A. Brown et al. in BNL)
 - Need periodic calibration by Al activation method
 - Radiation exposure in handling Al foils

SEC at the extraction point from KEK-PS



Beam profile measurement in KEK-PS extraction beam line

- Phosphor screen + Tube camera
 - Good visibility under high radiation environment
 - Need screen
 - Radiation damage of tube camera (CCD camera doesn't work.)
- Segmented Plate Ionization Chamber (SPIC)
 - Good S/N and stability under high radiation environment
 - Good cost performance
 - Need vacuum window (SUS 50 μ m)
 - Deterioration by beam irradiation (1-2 year operation at KEK-PS)





Requirements for the slow-extraction beam monitors in J-PARC

• Limit of on-hand maintenance

- KEK-PS EP1 beam line: $(12 \text{ GeV}) \times (6 \times 10^{12} \text{ proton} / 2.2 \text{ sec}) = 5.2 \text{ kW}$
- Average beam loss: 5.2 kW \times 10 % / 400 m = 1.3 W / m
- Residual dose rate on beam duct ~ 10 mSv/h (Exposure limit: $32 \mu \text{Sv/h}$)
- Limit of material thickness
 - Materials with 10^{-5} interaction rate (7.5 W for 750 kW)
 - Air: 7.5 mm (STP), 740 m (1Pa), Al: 4 μ m, Ti: 2.8 μ m, Fe: 1.7 μ m
- Radiation hardness
 - Typical requirements for beam line magnets $\sim 10^9 \,\text{Gy}$
- Limit of cost

- Typical number of monitors 20 (Current, Profile), 200 (Loss)

Residual Gas Beam Profile Monitor (RGBPM) in Low-Vacuum

- Collect electrons/ions in residual gas generated by protons
 - # of ion-pair ~ 6.2×10^8 pair / cm (10¹² protons, 1Pa vacuum)
- Complete non-destructive monitor
- Wide dynamic range
- Simple structure
- Reasonable cost

RGBPM prototype installed in vacuum chamber



Test results at the EP2 beam line



- Beam position dependence was observed correctly.
- Profile is wider than SPIC
- Need more studies to understand the working principle.





Other candidates for profile monitor

- Segmented Secondary Electron Monitors (SSEM)
 - Minimize material thickness
 - Need moving system
- Measure Optical Transition Radiation with radhard camera
 - Minimize material thickness (Ti/Carbon ~10µm)
 - Lifetime of rad-hard camera (CID/CMOS camera)

Beam Loss Monitor (BLM)

- Detect unexpected beam loss
- Make interlock signal to Machine Protection System (MPS)
- Air-ionization chamber used in 12GeV-PS is a good candidate.
 - Simple principle
 - Easy fabrication
 - Good cost performance

BLM prototype using HF-coaxial cable



Test results at the EP2 beam line



Electronics for beam monitors

- Charge integration in ~ 1 sec extraction time
- Make Interlock signal to MPS (BLM)

A prototype of VME-integrator board by Prof. Inaba and Saito



Difficulties to measure intensity of slow-extraction beam

- DCCT (DC Current Transformer)
 - Sensitivity limit: ~ 10 μ A (J-PARC full beam: ~50 μ A)
 - Unavailable for low current beam ($\sim 10^{12}$ ppp)
- Direct measurement of beam magnetic field by SQUID + High Temperature Superconducting magnetic shield (T. Watanabe et al. ,RIKEN)
 - Radiation damage of SQUID device ??
 - Need cooling device working in beam line
 - Expensive !
- Possible solution: Summing up RGBPM signals

Configuration of beam monitors in beam switching yard (SY)



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Configuration of beam monitors in HD-hall



Summary and future prospects

- **RGBPM** is feasible for J-PARC slow beam, but need more studies about profile width.
- BLM using coaxial cable working well.
- Electronics and control system is being designed with help of KEK electronics and online group.
- Beam test must be completed by KEK-PS shutdown.
- Need more idea about beam intensity monitors
- We need more help from outside.